Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/552,540	TANAKA ET AL.
Examiner	Art Unit

Patrick D. Niland

1714

	SEAR	CHED	
Class	Subclass	Date	Examiner
211	41.17	4/25/2007	PN
428	457 458 626		
524 ·	115 116 122		
524	138		
525	395 396 397		
525	523 534 538	,	
525	408 420 423		
525	429		
To	date	11/12/07	PN

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search in file. Inventor Name search	4/28/2007	PN		
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